


<b>Search Notes</b>  	<b>Application/Control No.</b>  10523669	<b>Applicant(s)/Patent Under Reexamination</b>  CHIAYEE ET AL.
	<b>Examiner</b>  TUAN C TO	<b>Art Unit</b>  3663

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
TEXT SEARCH UPDATED	04/4/2008	TT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner